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ORM PTO-1449 US Dept. of Commerce				ATTORNEY DOCKET NO. S		SERIAL NO	SERIAL NO.				
Patent and Trademark Office				ATML515 10/015			0/015,326				
				ATMI-515 10/015,326 APPLICANT							
INFORMAT	ION DI	SCLOSURE STA	TEMENT	Chongying Xu, et al.							
INFORMATION DISCLOSURE STATEMENT (use several sheets if necessary)				FILING DATE GROUP							
				December 13, 2001		ТВА					
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